Unit: mm

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π–MOSV)

# 2SK2835

# Chopper Regulator, DC-DC Converter and Motor Drive Applications

• Low drain–source ON resistance : RDS (ON) =  $0.56 \Omega$  (typ.) • High forward transfer admittance :  $|Y_{fs}| = 4.5 S$  (typ.)

• Low leakage current  $: I_{DSS} = 100 \mu A \text{ (max) (V}_{DS} = 200 \text{ V)}$ 

• Enhancement mode :  $V_{th} = 1.5 \sim 3.5 \text{ V (VDS} = 10 \text{ V, ID} = 1 \text{ mA)}$ 

### **Absolute Maximum Ratings (Ta = 25°C)**

Characteris	stics	Symbol	Rating	Unit	
Drain-source voltage		$V_{DSS}$	200	V	
Drain-gate voltage (Ro	<sub>SS</sub> = 20 kΩ)	$V_{DGR}$	200	٧	
Gate-source voltage		V <sub>GSS</sub>	±20	V	
Drain current	DC (Note 1)	I <sub>D</sub>	5	Α	
	Pulse (Note 1)	I <sub>DP</sub>	20		
Drain power dissipation	١	P <sub>D</sub>	1.3	W	
Single pulse avalanche	e energy (Note 2)	E <sub>AS</sub>	65	mJ	
Avalanche current		I <sub>AR</sub>	5	А	
Repetitive avalanche energy (Note 3)		E <sub>AR</sub>	0.13	mJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature ra	ange	T <sub>stg</sub>	-55~150	°C	

1.4±0.1 1.05±0.1 1.5±0.1 1.5-0.05 2.5±0.5 1.SOURCE 2.DRAIN 3.GATE 2-8M1B

Weight: 0.54 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

#### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to ambient	R <sub>th (ch-a)</sub>	96.1	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2:  $V_{DD}$  = 50 V,  $T_{ch}$  = 25°C (initial), L = 4.2 mH,  $R_G$  = 25  $\Omega$ ,  $I_{AR}$  = 5 A

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device.

Please handle with caution.

2SK2835



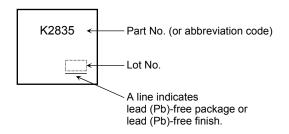
# **Electrical Characteristics (Ta = 25°C)**

Charac	eteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	rrent	I <sub>GSS</sub>	V <sub>GS</sub> = ±16 V, V <sub>DS</sub> = 0 V	_	_	±10	μΑ
Drain cut-off cur	rrent	I <sub>DSS</sub>	V <sub>DS</sub> = 200 V, V <sub>GS</sub> = 0 V	-	_	100	μΑ
Drain-source br	eakdown voltage	V (BR) DSS	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	200	_	_	V
Gate threshold v	voltage	V <sub>th</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	1.5	_	3.5	V
Drain-source Ol	N resistance	R <sub>DS</sub> (ON)	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 2.5 A		0.56	0.8	Ω
Forward transfer	admittance	Y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 2.5 A	2.0	4.5	_	S
Input capacitano	:e	C <sub>iss</sub>			440	_	pF
Reverse transfer capacitance		C <sub>rss</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz		35	_	
Output capacitance		C <sub>oss</sub>			120	_	
Switching time	Rise time	t <sub>r</sub>	V <sub>GS</sub> 10V I <sub>D</sub> =2.5A OVOUT R <sub>L</sub> =40Ω	_	15	_	- ns
	Turn-on time	t <sub>on</sub>		_	20	_	
	Fall time	t <sub>f</sub>		_	15	_	
	Turn-off time	t <sub>off</sub>	$V_{DD} = 100V$ Duty $\leq 1\%$ , $t_{W} = 10\mu s$	_	60	_	
Total gate charge (gate-source plus gate-drain)		Qg		_	10	_	
Gate-source charge		Q <sub>gs</sub>	$V_{DD} \approx 100 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$	_	6		nC
Gate-drain ("miller") Charge		Q <sub>gd</sub>	]		4	_	

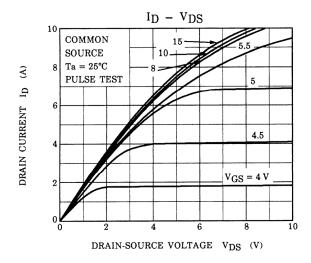
# Source-Drain Ratings and Characteristics (Ta = 25°C)

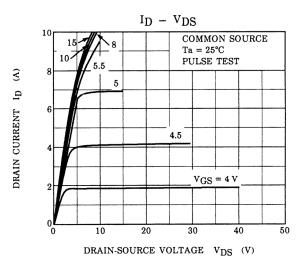
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I <sub>DR</sub>	_	_	_	5	Α
Pulse drain reverse current (Note 1)	I <sub>DRP</sub>	-	_	_	20	Α
Forward voltage (diode)	V <sub>DSF</sub>	I <sub>DR</sub> = 5 A, V <sub>GS</sub> = 0 V	_	_	-2.0	V
Reverse recovery time	t <sub>rr</sub>	$I_{DR} = 5 \text{ A}, V_{GS} = 0 \text{ V}, dI_{DR} / dt = 100 \text{ A} / \mu \text{s}$		150		ns
Reverse recovery charge	Q <sub>rr</sub>			0.45		μC

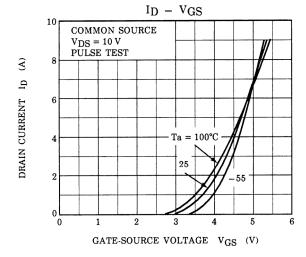
### Marking

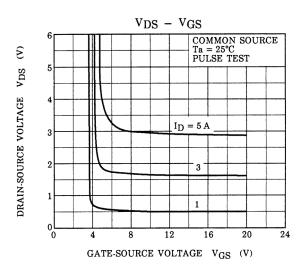


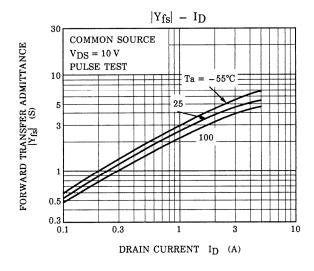
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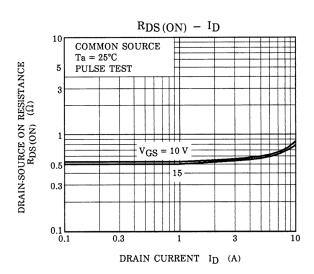


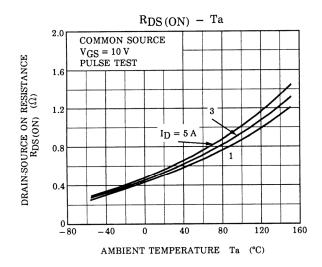


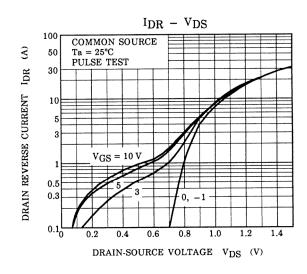


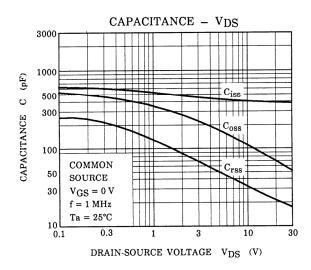


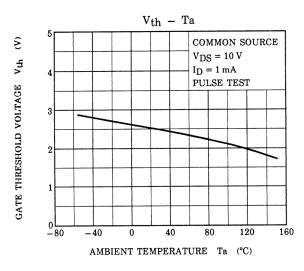


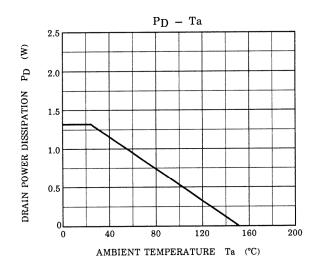


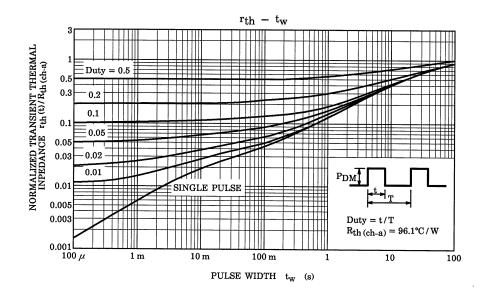


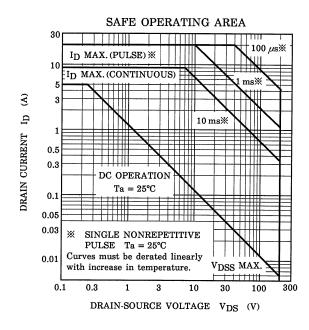


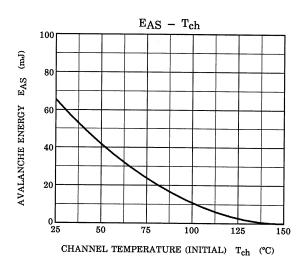


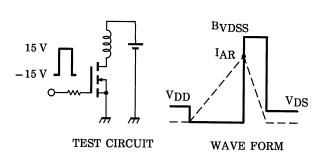












$$R_G$$
 = 25  $\Omega$   
 $V_{DD}$  = 25 V, L = 4.2 mH

$$EAS = \frac{1}{2} \cdot L \cdot I^{2} \cdot \left( \frac{BVDSS}{BVDSS - VDD} \right)$$

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